



HEXFET® Power MOSFET

Application

- Brushed Motor drive applications
- BLDC Motor drive applications
- PWM Inverterized topologies
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Electronic ballast applications
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters

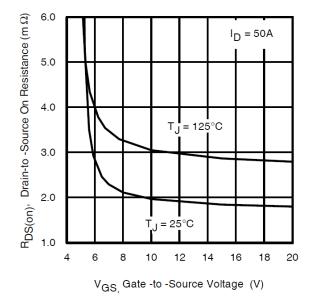
V _{DSS}	40V
R _{DS(on)} typ.	1.8mΩ
max	2.4mΩ
I _D	159A

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- RoHS Compliant containing no Lead, no Bromide, and no Halogen



Base next number	Dookogo Typo	Standard Pack		Ordereble Bert Number	Note
Base part number	Раскаде туре	Form	Quantity	Orderable Part Number	Note
IRFH7440PbF	PQFN 5mm x 6mm	Tape and Reel	4000	IRFH7440TRPbF	
	PQFN 5mm x 6mm	Tape and Reel	400	IRFH7440TR2PbF	EOL notice # 259





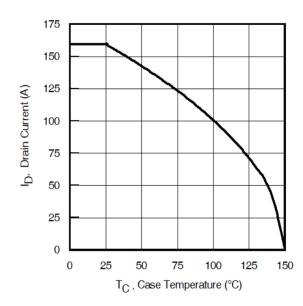


Fig 2. Maximum Drain Current vs. Case Temperature



Absolute Maximum Rating

Symbol	Parameter	Max.	Units
$I_D @ T_{C(Bottom)} = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V ①	159	
I _D @ T _{C(Bottom)} = 100°C	Continuous Drain Current, V _{GS} @ 10V ①	101	Α
I _{DM}	Pulsed Drain Current ②	636	
P _D @ T _C = 25°C	Maximum Power Dissipation	104	W
	Linear Derating Factor	0.83	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery®	3.0	V/ns
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 150	°C

Avalanche Characteristics

Symbol	Parameter	Max.	Units
E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ③	121	m l
E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ®	232	mJ
I _{AR}	Avalanche Current ②	Soc Fig 15, 16, 22c, 22h	Α
E _{AR}	Repetitive Avalanche Energy ②	See Fig 15, 16, 22a, 22b	mJ

Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{θJC} (Bottom)	Junction-to-Case		1.2	
R ₀ JC (Top)	Junction-to-Case ®		31	°C/W
$R_{ hetaJA}$	Junction-to-Ambient ®		35	C/VV
R _{θJA} (<10s)	Junction-to-Ambient ®		22	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.031		mV/°C	Reference to 25°C, I _D = 1.0mA
В	Static Drain-to-Source On-Resistance		1.8	2.4	mΩ	$V_{GS} = 10V, I_D = 50A$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance		2.7			$V_{GS} = 6.0V, I_D = 25A$
$V_{GS(th)}$	Gate Threshold Voltage	2.2		3.9	V	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$
I _{DSS}	Drain-to-Source Leakage Current			1.0		$V_{DS} = 40V$, $V_{GS} = 0V$
				150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I_{GSS}	Gate-to-Source Forward Leakage			100	nΛ	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
R_G	Gate Resistance		2.6		Ω	

Notes:

- ① Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- \odot Limited by T_{Jmax}, starting T_J = 25°C, L = 0.097mH, R_G = 50 Ω , I_{AS} = 50A, V_{GS} = 10V.

- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1 inch square 2 oz copper pad on 1.5 x 1.5 in. board of FR-4 material.
- $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$
- \odot Limited by T_{Jmax}, starting T_J = 25°C, L = 1mH, R_G = 50 Ω , I_{AS} = 22A, V_{GS} =10V.



Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	149			S	$V_{DS} = 10V, I_{D} = 50A$
Q_g	Total Gate Charge		92	138		I _D = 50A
Q_{gs}	Gate-to-Source Charge		22			$V_{DS} = 20V$
Q_{gd}	Gate-to-Drain Charge		29		nC	V _{GS} = 10V ⑤
Q _{sync}	Total Gate Charge Sync. (Qg - Qgd)		63			
$t_{d(on)}$	Turn-On Delay Time		12			$V_{DD} = 20V$
t _r	Rise Time		45			I _D = 30A
$t_{d(off)}$	Turn-Off Delay Time		53		ns	$R_G = 2.7\Omega$
t _f	Fall Time		42			V _{GS} = 10V ⑤
C _{iss}	Input Capacitance		4574			V _{GS} = 0V
C _{oss}	Output Capacitance		700			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		466		рF	f = 1.0MHz
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		863			V _{GS} = 0V, V _{DS} = 0V to 32V⑦
Coss eff.(TR)	Output Capacitance (Time Related)		1229			$V_{GS} = 0V$, $V_{DS} = 0V$ to 32V®

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			80	_	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ②			636	I	integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage		0.9	1.3	V	$T_J = 25^{\circ}C, I_S = 50A, V_{GS} = 0V $
t _{rr}	Reverse Recovery Time		25		ns	$T_J = 25^{\circ}C$ $V_{DD} = 34V$
	D Ol		27 16			$T_J = 125^{\circ}C$ $I_F = 50A$, $T_J = 25^{\circ}C$ $di/dt = 100A/\mu s$ \bigcirc
Q _{rr}	Reverse Recovery Charge		17		nC	<u>T_J = 125°C</u>
I _{RRM}	Reverse Recovery Current		1.2		Α	$T_J = 25^{\circ}C$



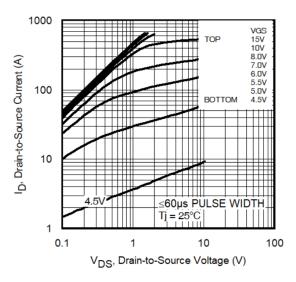


Fig 3. Typical Output Characteristics

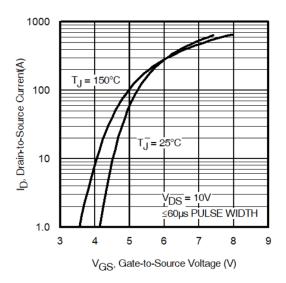


Fig 5. Typical Transfer Characteristics

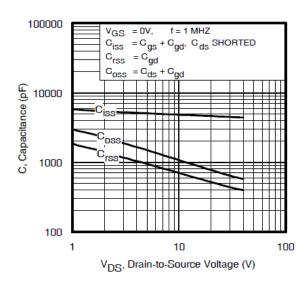


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

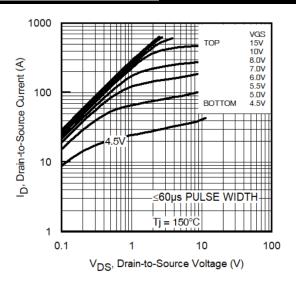


Fig 4. Typical Output Characteristics

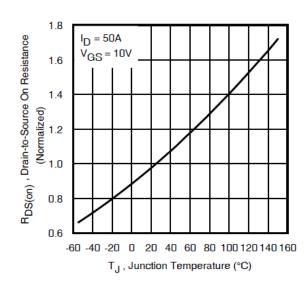


Fig 6. Normalized On-Resistance vs. Temperature

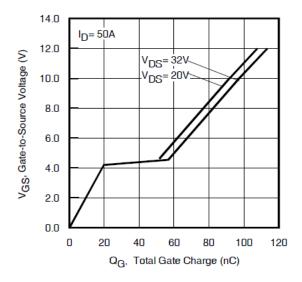


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage

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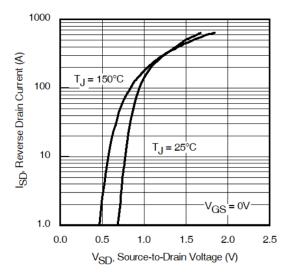


Fig 9. Typical Source-Drain Diode Forward Voltage

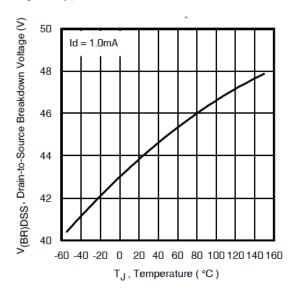


Fig 11. Drain-to-Source Breakdown Voltage

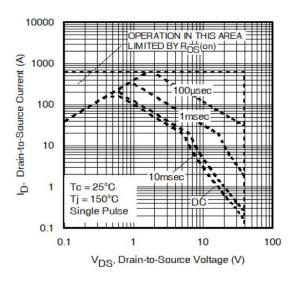


Fig 10. Maximum Safe Operating Area

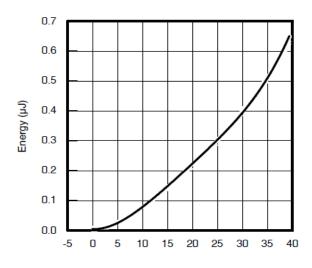


Fig 12. Typical Coss Stored Energy

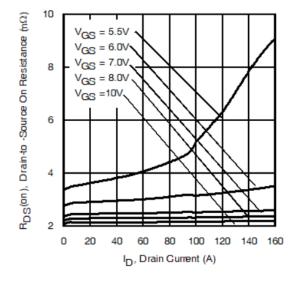


Fig 13. Typical On-Resistance vs. Drain Current

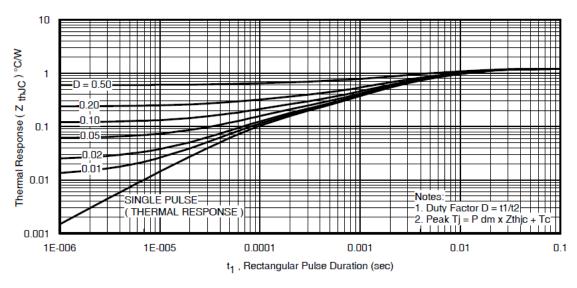


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

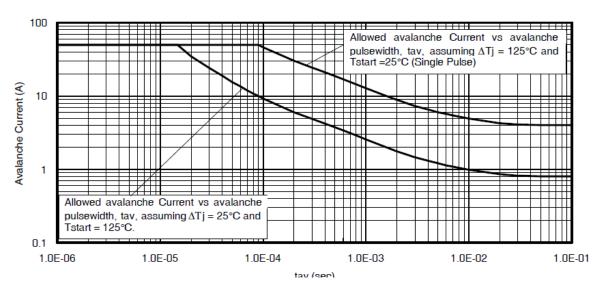


Fig 15. Typical Avalanche Current vs. Pulse Width

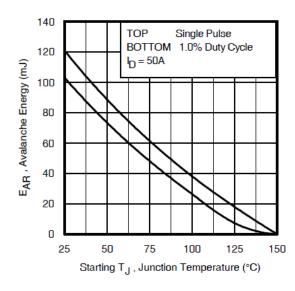


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{imax} (assumed as 25°C in Figure 14, 16). t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

PD (ave) = 1/2 ($1.3 \cdot BV \cdot I_{av}$) = $\Delta T/Z_{thJC}$ $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$ $E_{AS (AR)} = P_{D (ave)} t_{av}$



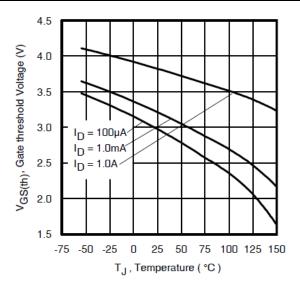
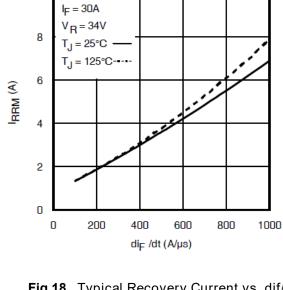


Fig 17. Threshold Voltage vs. Temperature



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Fig 18. Typical Recovery Current vs. dif/dt

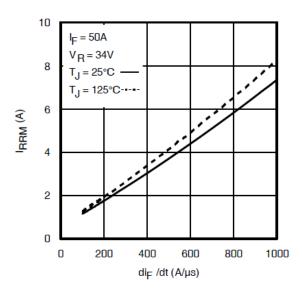


Fig 19. Typical Recovery Current vs. dif/dt

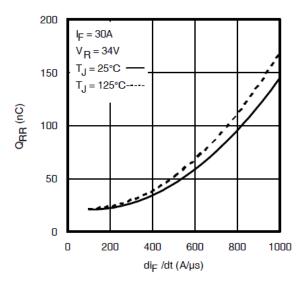


Fig 20. Typical Stored Charge vs. dif/dt

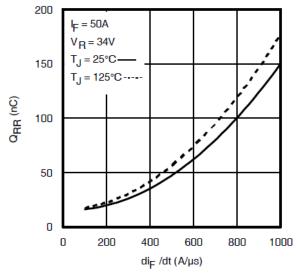


Fig 21. Typical Stored Charge vs. dif/dt



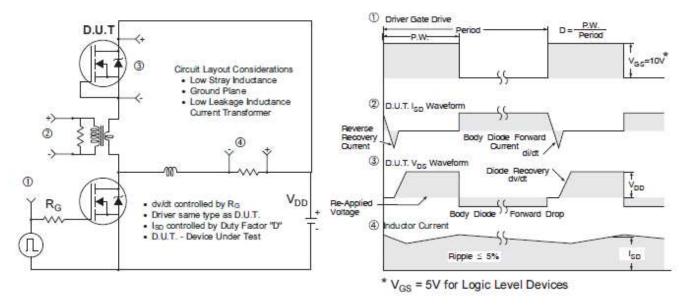


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

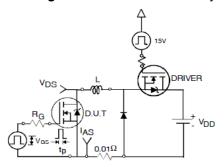


Fig 23a. Unclamped Inductive Test Circuit

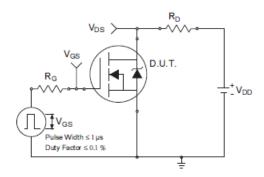


Fig 24a. Switching Time Test Circuit

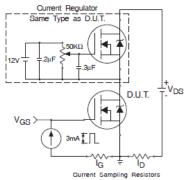


Fig 25a. Gate Charge Test Circuit

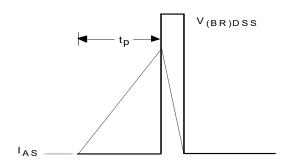


Fig 23b. Unclamped Inductive Waveforms

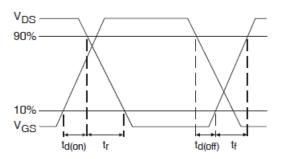


Fig 24b. Switching Time Waveforms

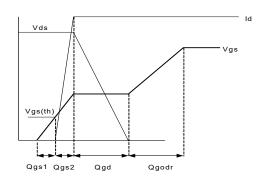


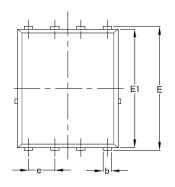
Fig 25b. Gate Charge Waveform

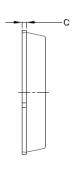
Rev. 2.5, 2020-04-16

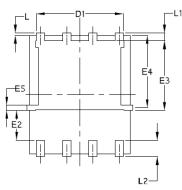
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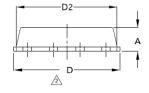


PQFN 5x6 Outline "E" Package Details



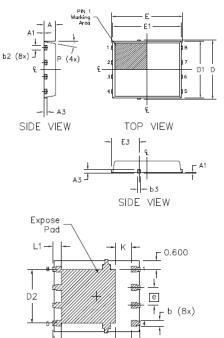






S Y	COMMON						
M B	IV	1M	INCH				
O L	MIN.	MAX.	MIN.	MAX.			
Α	0.90	1.17	0.0354	0.0461			
b	0.33	0.48	0.0130	0.0189			
С	0.195	0.300	0.0077	0.0118			
D	4.80	5.15	0.1890	0.2028			
D1	3.91	4.31	0.1539	0.1697			
D2	4.80	5.00	0.1890	0.1968			
Е	5.90	6.15	0.2323	0.2421			
E1	5.65	6.00	0.2224	0.2362			
E2	1.51		0.0594	_			
E3	3.32	3.78	0.1307	0.1480			
E4	3.42	3.58	0.1346	0.1409			
E5	0.18	0.32	0.0071	0.0126			
е	1.27	BSC	0.050	BSC			
L	0.05	0.25	0.0020	0.0098			
L1	0.38	0.66	0.0150	0.0260			
L2	0.51	0.86	0.0201	0.0339			
	0	0.18	0	0.0071			

PQFN 5x6 Outline "G" Package Details



BOTTOM VIEW

	1 (11 1 1)				
DIM	MILLIMETERS		II.	VCH	
SYMBOL	MIN.	MAX.	MIN.	MAX.	
Α	0.950	1.050	0.0374	0.0413	
A1	0.000	0.050	0,0000	0.0020	
А3	0.254	REF	0.0100	REF	
Ь	0.310	0.510	0.0122	0.0201	
b1	0.025	0.125	0.0010	0.0049	
b2	0.210	0.410	0.0083	0.0161	
b3	0.180	0.450	0.0071	0.0177	
D	5.150	BSC	0.2028 BSC		
D1	5.000	BSC	0.1969 BSC		
D2	3.700	3.900	0.1457	0.1535	
E	6.150	BSC	0.2421 BSC		
E1	6.000	BSC	0.2362 BSC		
E2	3.560	3.760	0.1402	0.1488	
E3	2.270	2.470	0.0894	0.0972	
е	e 1.27 REF		0.050	REF	
K	0.830	1.400	0.0327	0.0551	
L	0.510	0.710	0.0201	0.0280	
L1	0.510	0.710	0.0201	0.0280	
Р	10 deg	12 deg	0 deg	12 deg	

Note:

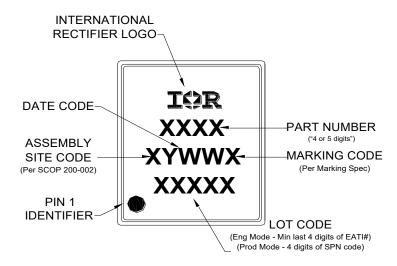
- Dimensions and toleranceing confirm to ASME Y14,5M-1994
- Dimension L represents terminal full back from package edge up to 0.1mm is acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4. Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf

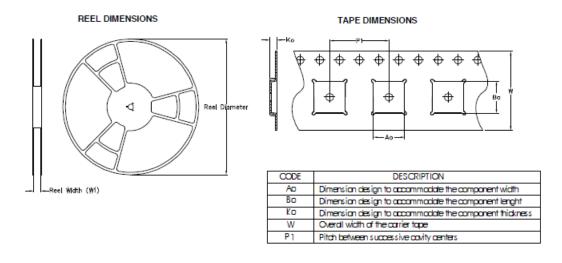
For more information on package inspection techniques, please refer to application note AN-1154: Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



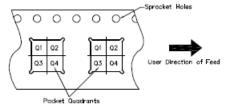
PQFN 5x6 Part Marking



PQFN 5x6 Tape and Reel



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Nate: All almension are nominal

	Paakage Type	Reel Diameter (Inch)	QΤΥ	Reel Wiatth W1 (mm)	An (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5	XóPQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	ପା

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

Qualification level	Industrial (per JEDEC JESD47F [†] guidelines)				
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D ^{†)}			
RoHS Compliant	Yes				

[†] Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Rev	Comments
01/13/2014	2.1	 Updated ordering information to reflect the End-Of-Life (EOL) of the mini-reel option (EOL notice #259). Updated data sheet with the new IR corporate template.
02/19/2015	2.2	 Updated EAS (L =1mH) = 232mJ on page 2 Updated note 10 "Limited by TJmax, starting T_J = 25°C, L = 1mH, R_G = 50Ω, I_{AS} = 22A, V_{GS} =10V". on page 2
06/2/2015	2.3	 Updated package outline for "option E" and added package outline for "option G" on page 9. Updated "IFX" logo on page 1 & 11. Updated tape and reel on page 10.
07/07/2015	2.4	Corrected package outline for "option E" on page 9.
04/16/2020	2.5	 Updated datasheet based on IFX template. Updated Datasheet based on new current rating and application note :App-AN_1912_PL51_2001_180356



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